Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/680,620	VENKATESH ET AL.	
Examiner	**Art Unit**	
Betsy L. Deppe	2611	

SEARCHED			
Class	Subclass	Date	Examiner
375	345	12/18/2006	BD
455	232.1	12/18/2006	BD
455	234.1	12/18/2006	BD
341	139	12/18/2006	BD
455	245.1	12/19/2006	BD
330	254	12/19/2006	BD
330	278	12/19/2006	BD
updated	search	8/9/2007	BD

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor name search	12/18/2006	BD
PLUS search	12/18/2006	BD
Text search (USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB)	12/19/2006	BD
Text search (USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM-TDB)	8/9/2007	BD